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1 An efficient method to characterise the performance of metal oxide varistors

Perrot, F.;

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Pages: 305 - 308 vol. 2

[Abstract] [PDF Full-Text (256 KB)] **IEE CNF**

2 Measuring the energy handling capability of metal oxide varistors

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Electricity Distribution, 2001. Part 1: Contributions. CIRED. 16th International Conference and Exhibition on (IEE Conf. Publ No. 482), Volume: 1, 18-21 June 2001

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Conduction and Breakdown in Solid Dielectrics, 1995. ICSD'95., Proceedings of the 1995 IEEE 5th International Conference on , 10-13 July 1995 Pages:498 - 502

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4 A study on the microstructure and surge characteristics of ZnO varistor for distribution arrester

Kim, S.S.; Cho, H.G.; Choi, I.S.; Park, T.G.; Park, C.H.; Jung, S.Y.; Power System Technology, 2002. Proceedings. PowerCon 2002. International Conference on , Volume: 4 , 13-17 Oct. 2002 Pages: 2212 - 2217 vol.4

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Shirai, Y.; Miyato, Y.; Taguchi, M.; Shiotsu, M.; Hatta, H.; Muroya, S.; Chiba, M.; Nitta, T.;

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